

# Supporting Information for

## Charge Carrier Lifetimes Exceeding 15 Microseconds in Methylammonium Lead Iodide Single Crystals

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### KINETIC MODEL:

The following set of coupled differential equations was used to model the concentrations of electrons in the conduction band ( $n_e$ ), holes in the valence band ( $n_h$ ) and trapped electrons ( $N_T$ ) as function of time after photo-excitation of the perovskite single crystal:

$$\frac{dn_e}{dt} = G_c - k_2 n_e (n_h + p_0) - k_T n_e (N_T - n_t) \quad (1)$$

$$\frac{dn_h}{dt} = G_c - k_2 n_e (n_h + p_0) - k_R n_t (n_h + p_0) \quad (2)$$

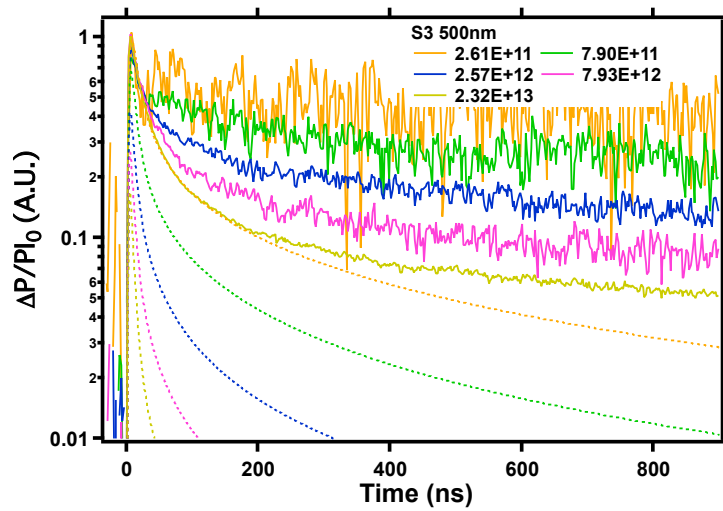
$$\frac{dn_t}{dt} = k_T n_e (N_T - n_t) - k_R n_t (n_h + p_0) \quad (3)$$

For a full description of this kinetic model, see Hutter *et al.*, *J. Phys. Chem. Lett.* **2015**, 6, 3082–3090 (Ref. (29) in the main text).

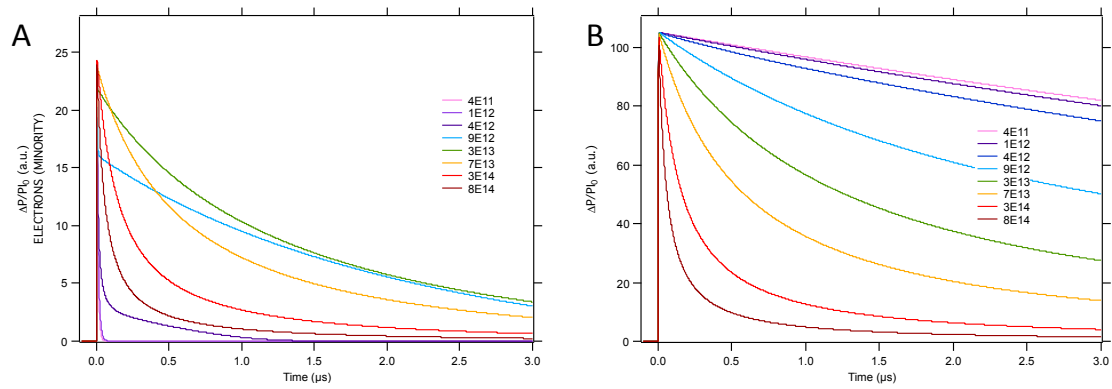
Table S1 lists the kinetic parameters that were used to model both the PL and TRMC lifetimes.

$k_2$ (cm <sup>3</sup> s <sup>-1</sup> )	$5.5 \times 10^{-9}$
$k_T$ (cm <sup>3</sup> s <sup>-1</sup> )	$9 \times 10^{-6}$
$k_R$ (cm <sup>3</sup> s <sup>-1</sup> )	$2 \times 10^{-9}$
$N_T$ (cm <sup>-3</sup> )	$1.5 \times 10^{13}$
$p_0$ (cm <sup>-3</sup> )	$4 \times 10^{13}$
$\Sigma\mu_h$ *(cm <sup>2</sup> /Vs)	105
$\Sigma\mu_e$ *(cm <sup>2</sup> /Vs)	25

**Table S1. Kinetic parameters used to model the TRMC measurements** (see Fig. 3 in the main text). Here,  $k_2$ ,  $k_T$  and  $k_R$  are the rate constants for band-to-band electron-hole recombination, trap filling and trap emptying, respectively.  $N_T$  denotes the concentration of trap states,  $p_0$  is the background hole concentration at thermal equilibrium. Finally,  $\mu_e$  and  $\mu_h$  are the mobilities of electrons (e) and holes (h), obtained from Ref. (20) in the main text.



**Figure S1.** Calculated TRMC traces for excitation at 500 nm using same parameters as excitation at 845 nm. (When we excite our single crystal at 500 nm, it yields an extremely non-uniform charge carrier distribution in the single crystal)



**Figure S2.** Calculated TRMC traces for charge carriers at different excitation intensities. (A) Conduction band electrons and (B) valence band holes (photons/cm<sup>2</sup>,  $\lambda = 845$  nm). Note that the experimental TRMC traces are always the sum of A and B.